

Tailored sample designs for ultrafast electron diffraction at high repetition rates

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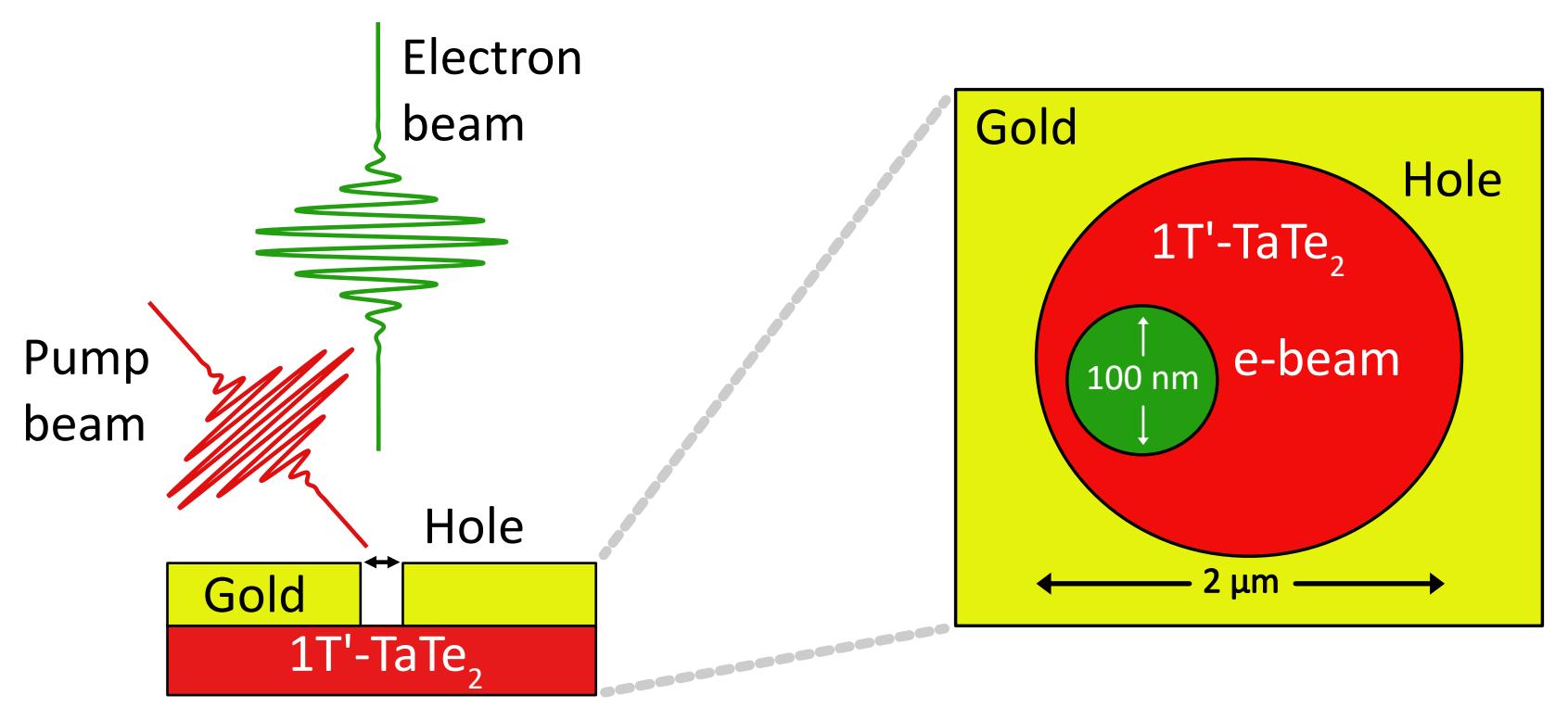
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Motivation

- Ultrafast Electron Diffraction (UED) [1] is a powerful technique to resolve structural dynamics in strongly correlated materials.
- The Göttingen Ultrafast Transmission Electron Microscope (UTEM) [2] provides **nanometric** e-beam diameters, which give access to nanoscale heterogeneity that can impact the dynamics [3][4].
- The diffraction signal critically depends on the available duty cycle.
- A critical complication arises from the **cumulative heating** of the sample at high repetition rates.
- Create a sample design tailored to
 - Confine the laser excitation volume
 - Efficiently dissipate the thermal load

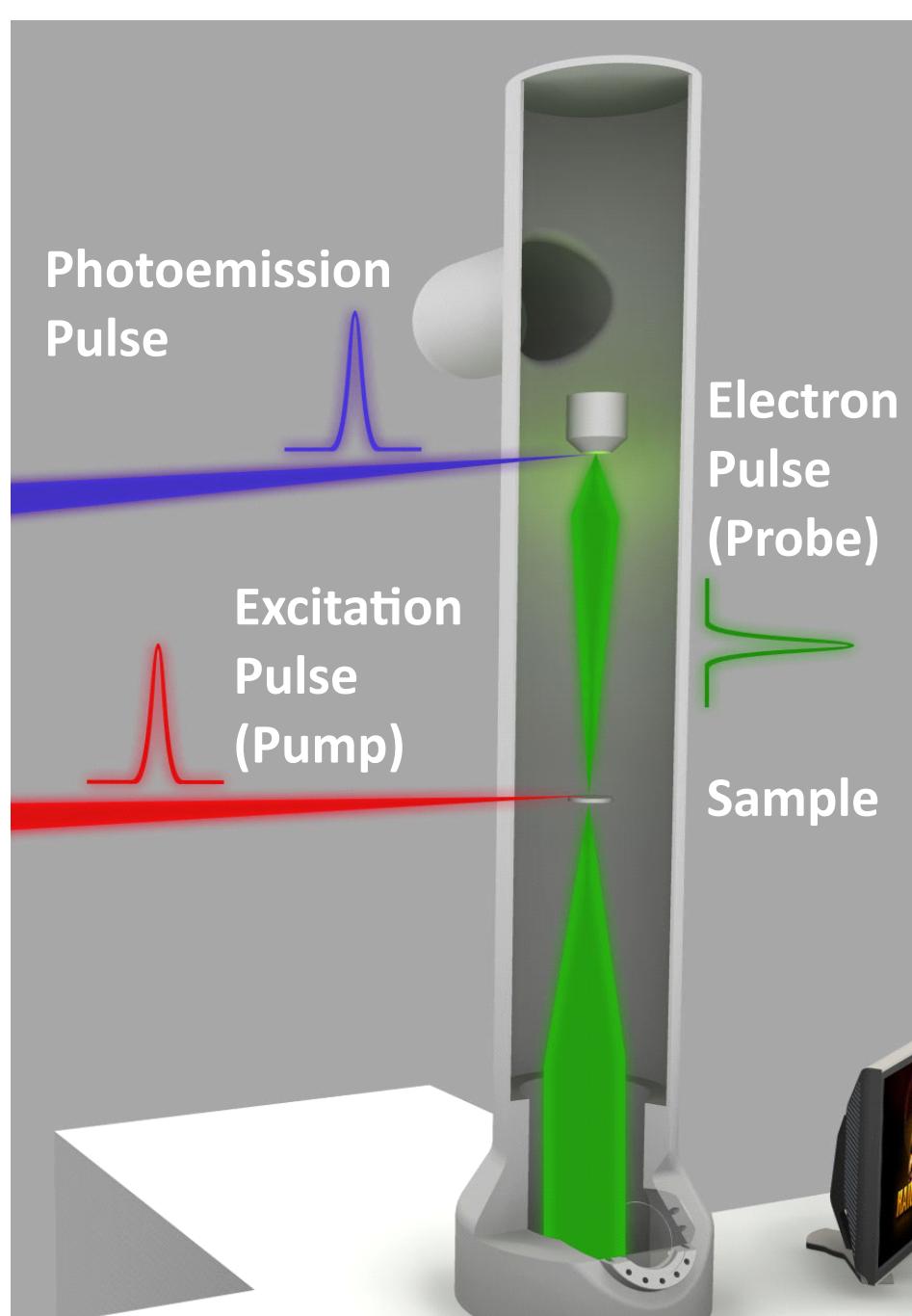
Experimental Setup

Sample excitation in time-resolved UED experiment



Pump beam excitation of the sample and subsequent electron beam probing

Samples top view where crystal lies under gold mask and electrons probe a specific region



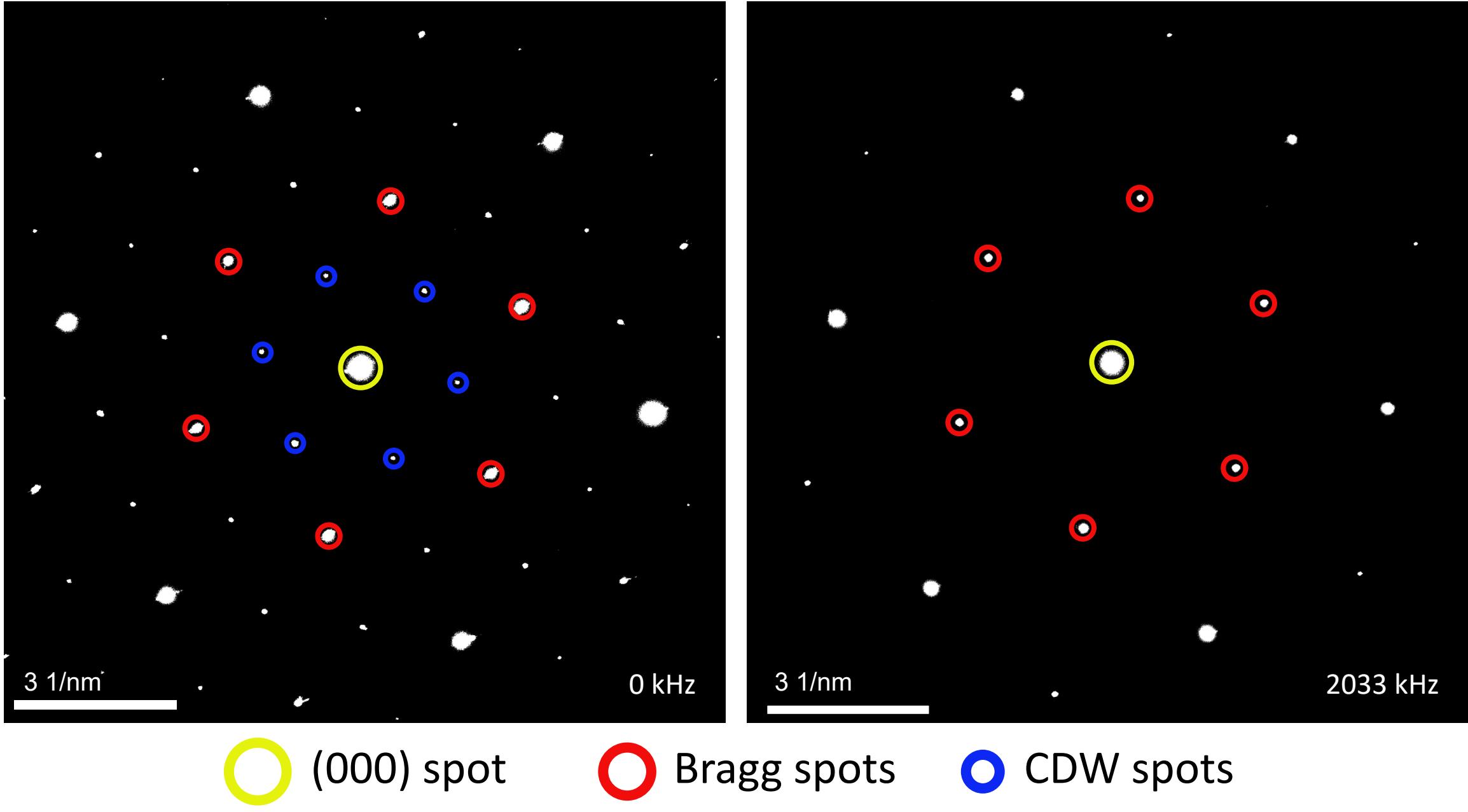
Ultrafast Transmission Electron Microscopy (UTEM) scheme

Electrons E_{kin}	120 keV
$d_{\text{e-beam}}$	100 nm
$\text{FWHM}_{\text{Laser}}$	25 μm
λ_{Laser}	800 nm
τ_{Laser}	50 fs

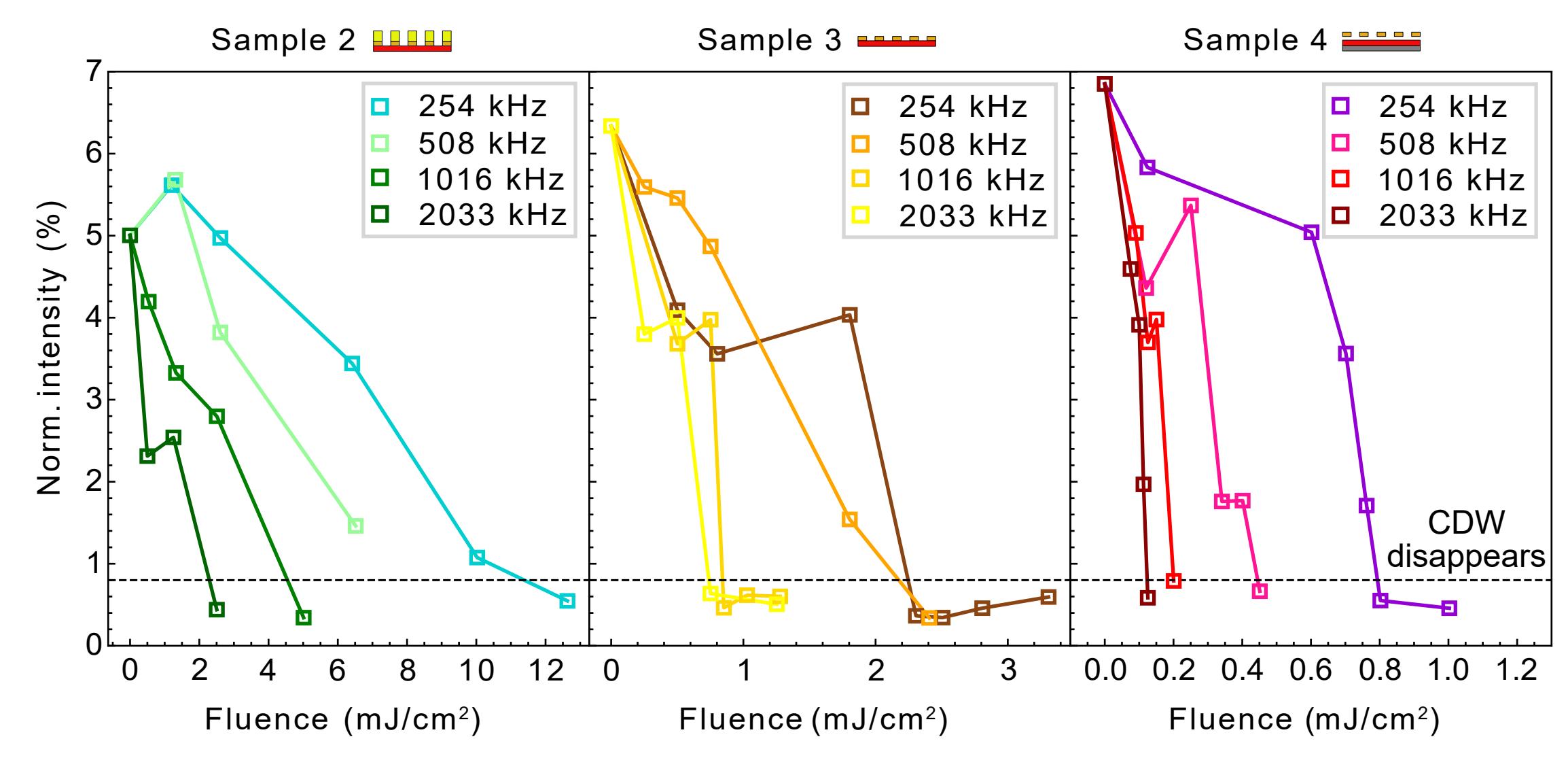
- Gold in the sample design provides a
- High thermal conductivity
 - High reflectivity

Thermal characterization of different sample designs

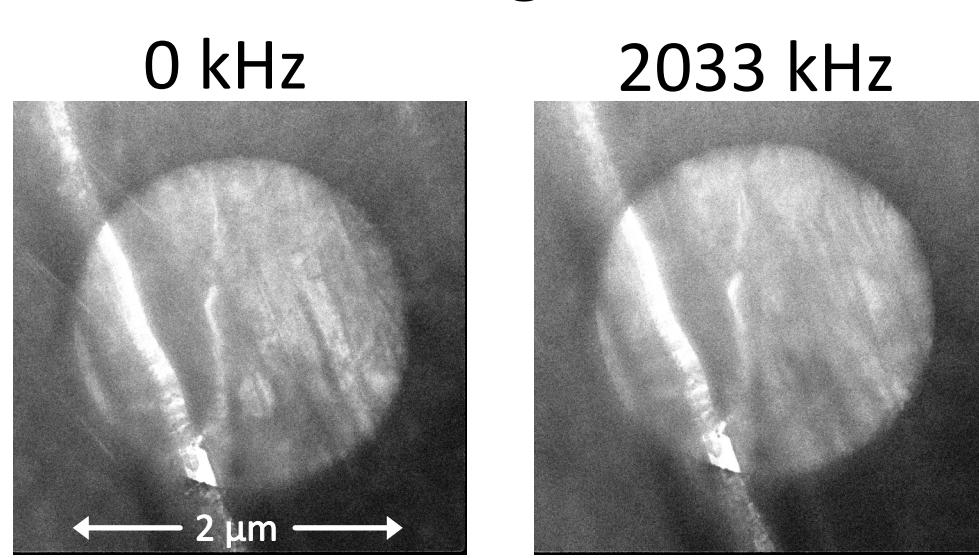
Sample 3 electron diffraction images



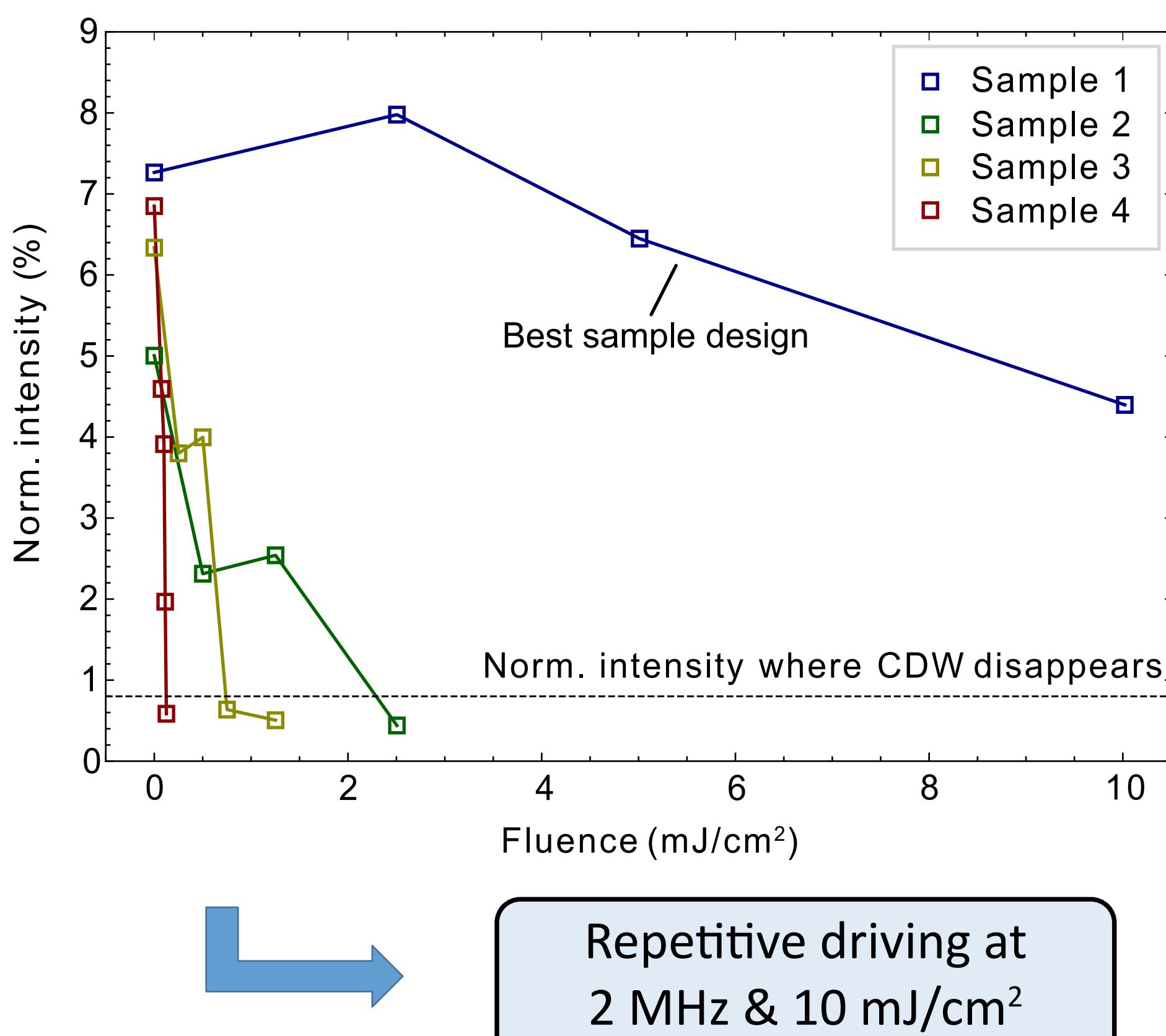
Fluence dependent heating of the samples 2 to 4 for different pump laser repetition rates



Sample 3 Real space TEM images



Fluence dependent heating for samples 1 to 4 at 2033 kHz pump laser repetition rate



- Continuous electron beam & pulsed pump laser.
- CDW spot intensity is directly related to sample temperature in the probed region.

Heat dissipation simulation

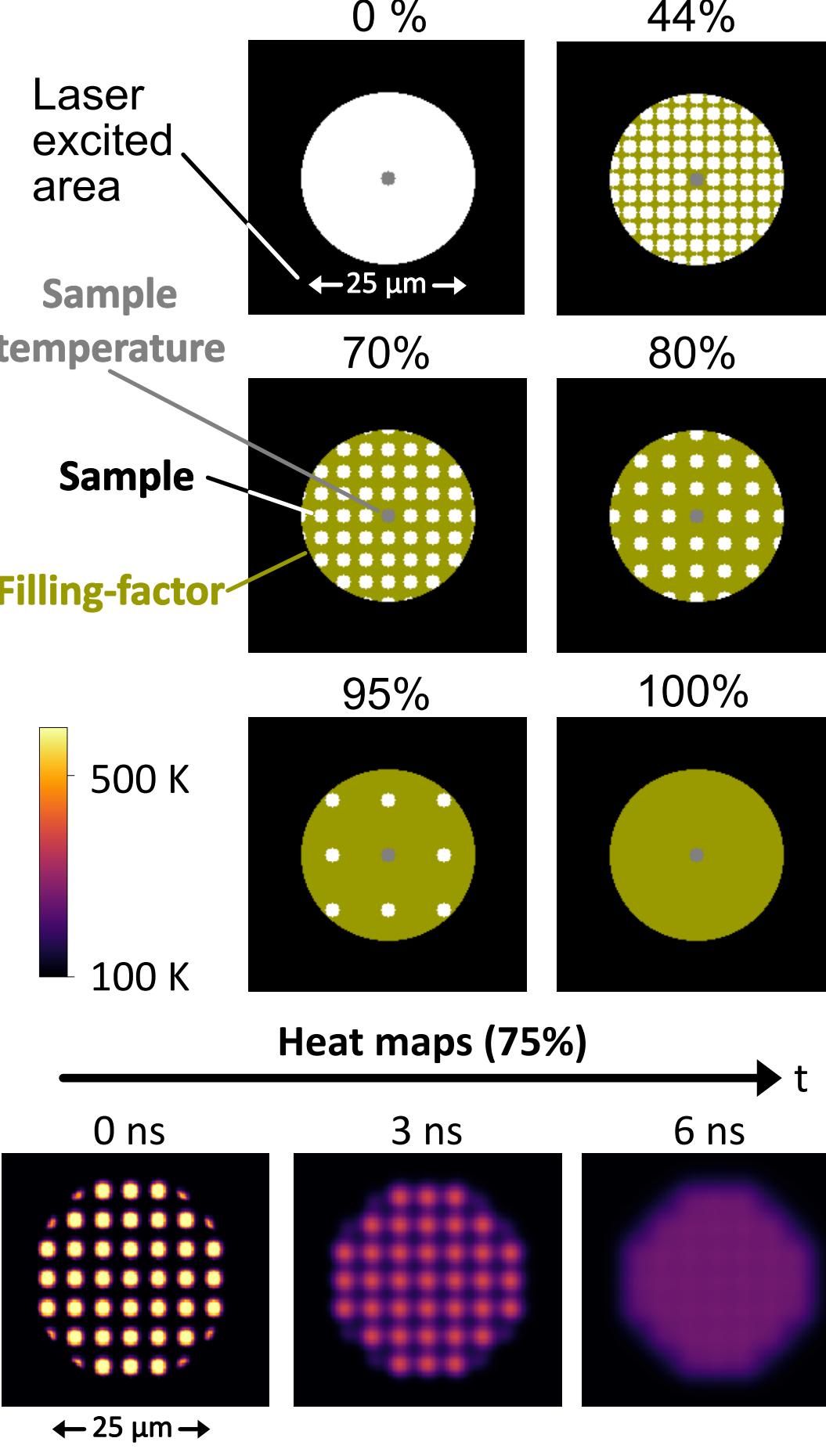
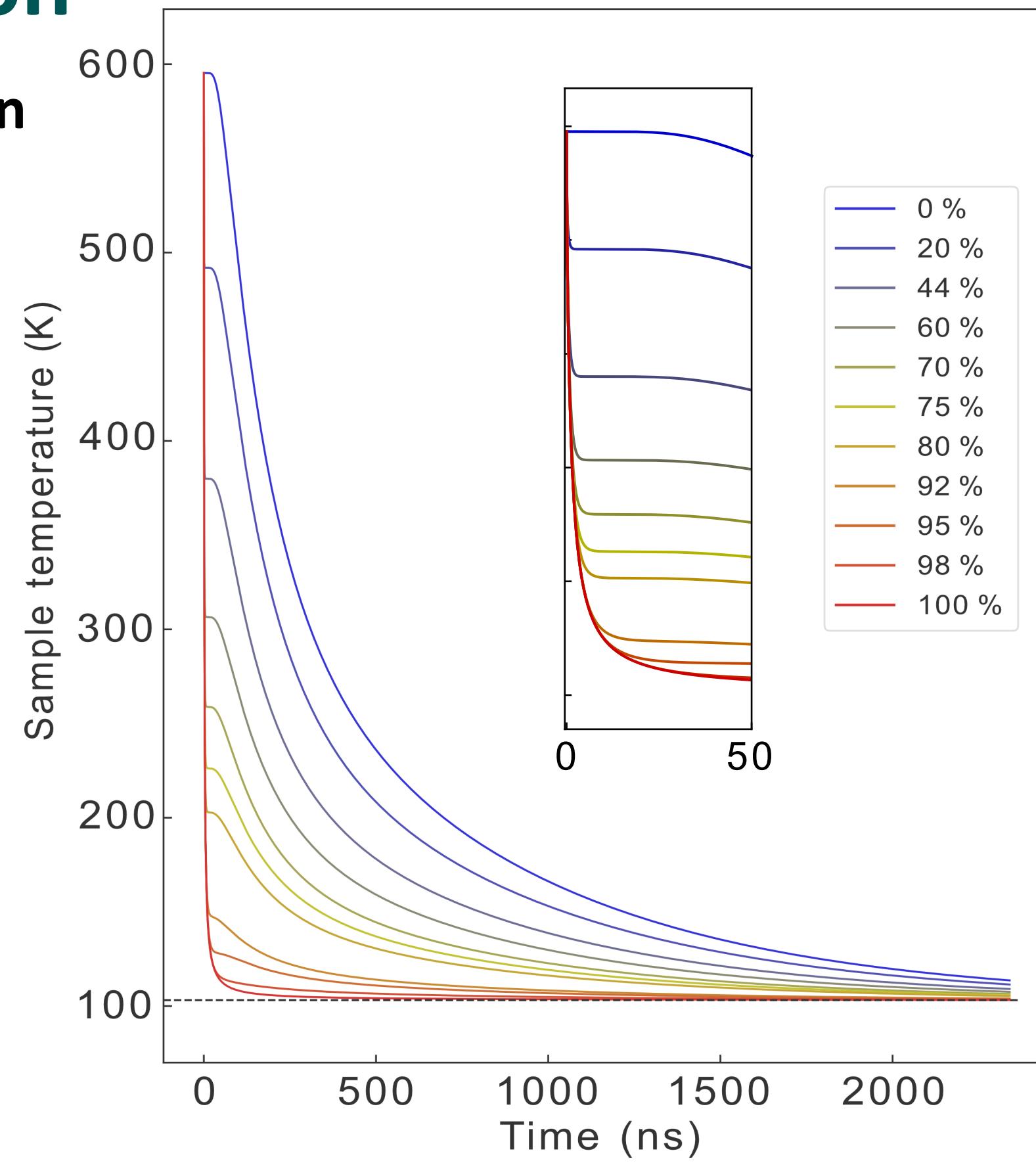
Gold based 2D heat diffusion equation

$$\frac{\partial^2 T}{\partial x^2} + \frac{\partial^2 T}{\partial y^2} = \frac{1}{\alpha} \frac{\partial T}{\partial t} \quad \alpha = \frac{K}{\rho C_p} \quad [6]$$

K	Thermal conductivity
ρ	Specific heat capacity
C_p	Mass density

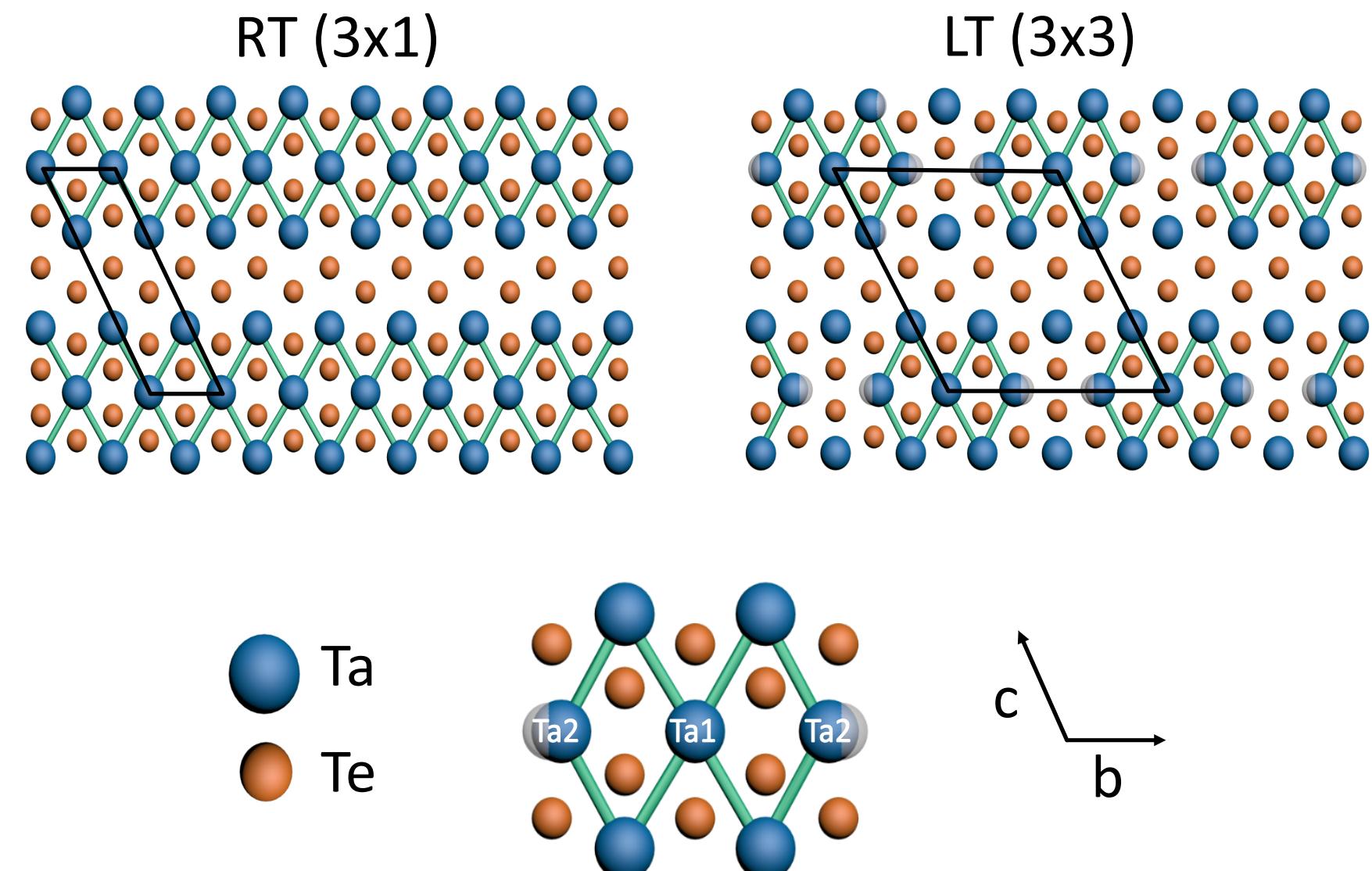
Filling-factor: Percentage in the laser excited area, which does not undergo a temperature increase.

Heat dissipation is strongly coupled to the filling-factor



Material system: 1T'-TaTe₂

RT (3x1)

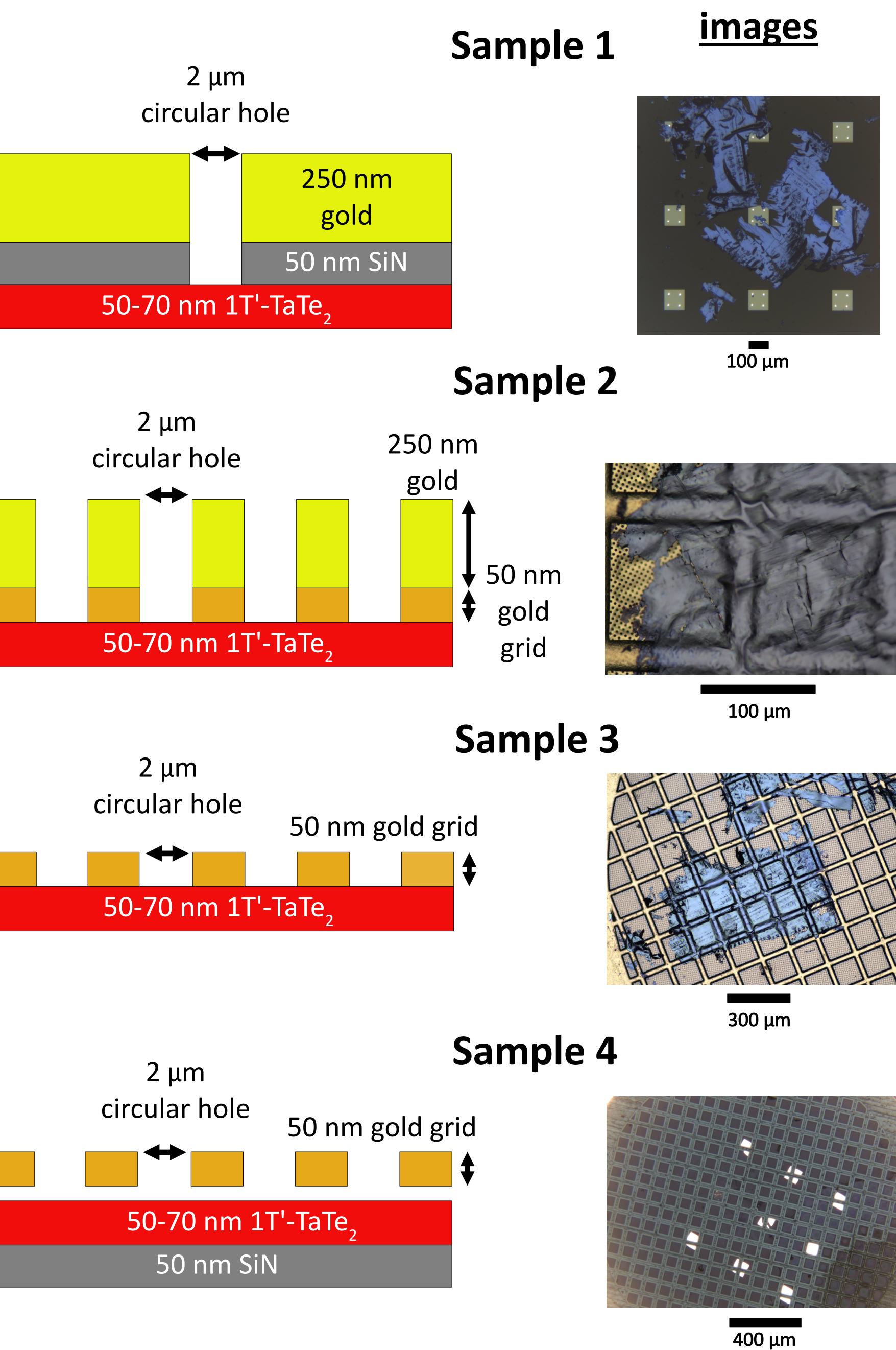


- The transition metal dichalcogenide (TMDC) 1T'-TaTe₂ is a strongly correlated material, which crystallizes at room temperature (RT) in a **3x1** superstructure [5].

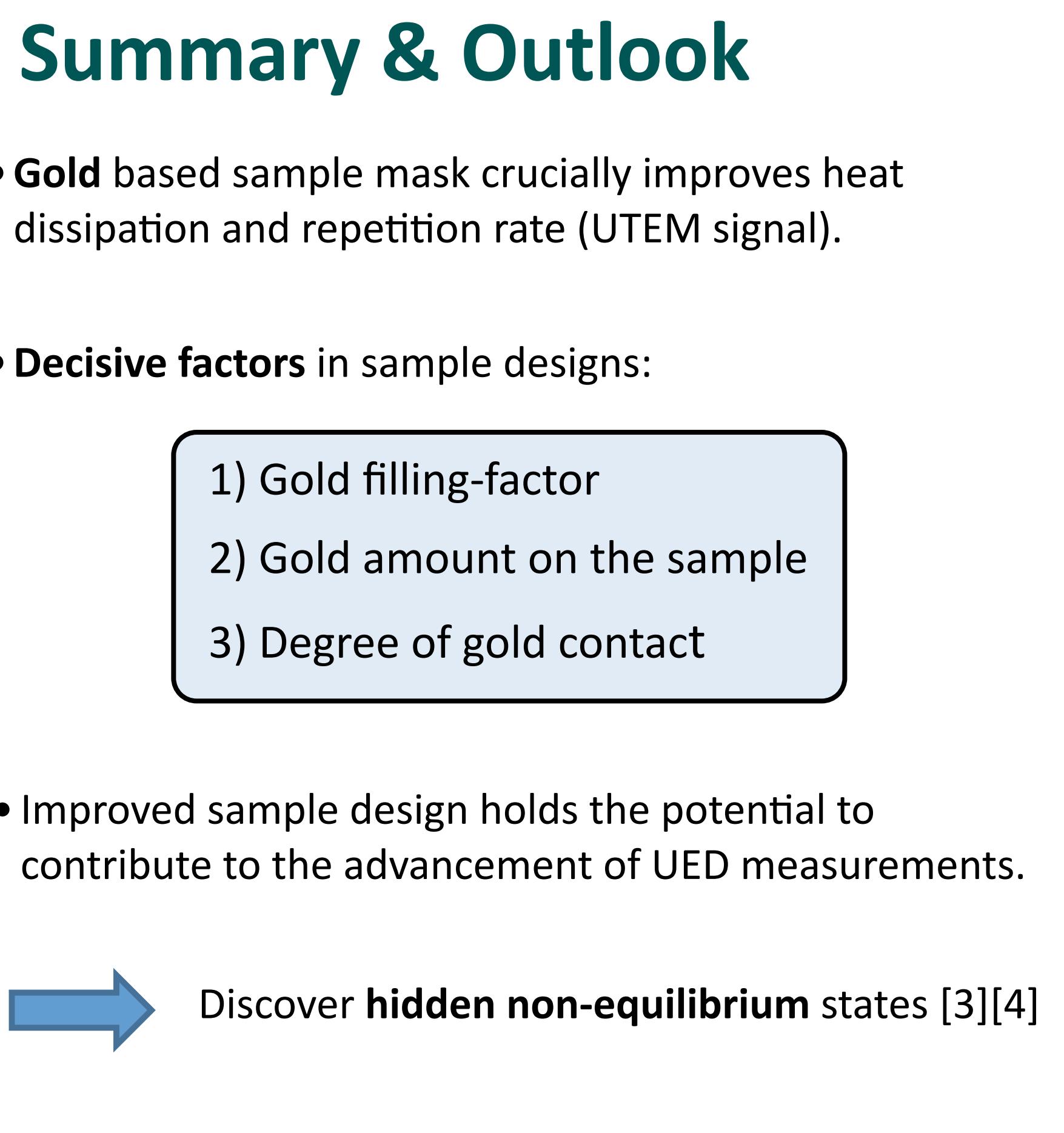
- In the low temperature (LT) regime below 174 K, 1T'-TaTe₂ transforms into a **3x3** superstructure by forming a Charge Density Wave (CDW) [5].

Sample Designs

Sample structure



Light microscope images



Summary & Outlook

- Gold based sample mask crucially improves heat dissipation and repetition rate (UTEM signal).

- Decisive factors in sample designs:

- Gold filling-factor
- Gold amount on the sample
- Degree of gold contact

- Improved sample design holds the potential to contribute to the advancement of UED measurements.

Discover hidden non-equilibrium states [3][4]

References

- [1] D. Filippetto et al., Rev. Mod. Phys. 94, 045004 (2022)
[2] A. Feist et al., Ultramicroscopy 176, 63 (2017)
[3] T. Domröse et al., Nat. Mater. 22, 1345-1351 (2023)
[4] T. Domröse et al., arXiv:2402.02931 [cond-mat.mtrl-sci] (2024)
[5] T. Sörgel et al., Mater. Res. Bulletin 41, 987-1000 (2006)
[6] Y. Cengel et al., McGraw-Hill Edu., ed. 5 (2015)

Acknowledgements

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